

# **Notice of References Cited**

Application/Control No.

09/842,161

Applicant(s)/Patent Under  
Reexamination  
IWAI ET AL.

Examiner

Gina C. Yu

Art Unit

1617

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6066316	05-2000	Shiojima et al.	--
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

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